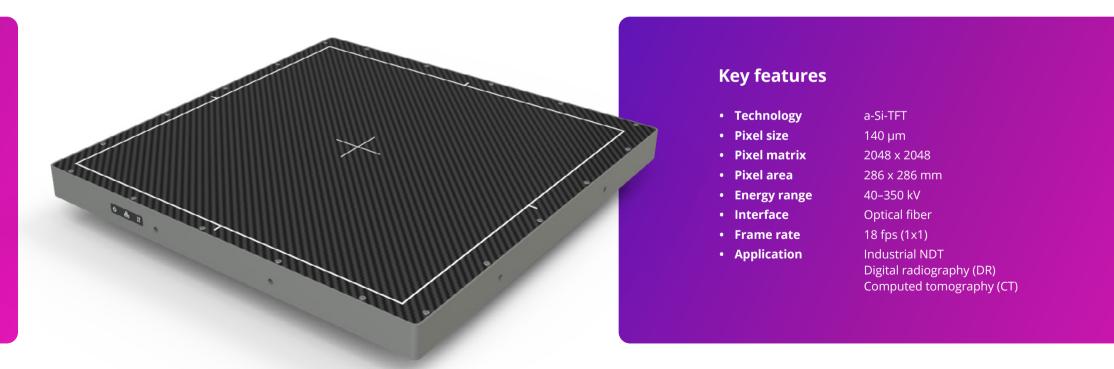
- PANEL® 3030a FPI-M



Fixed a-Si-TFT X-ray flat panel detector





X-Panel 3030a FPI-M is a fixed type and low noise X-ray flat panel detector optimized for industrial non-destructive testing (NDT), digital radiography (DR) and computed tomography (CT) applications. It is based on amorphous silicon (a-Si) technology that features a high dynamic range and a long lifetime among other benefits.

X-Panel 3030a FPI-M has good image quality and a large dynamic range. Furthermore, it comes with multiple gain modes, that make it compatible with both high sensitivity and large dynamic range requirements.

Technical specifications

Technology	
Sensor	a-Si-TFT
Scintillator	GOS / CSI
Active area	286 x 286 mm
Pixel matrix	2048 x 2048
Pixel pitch	140 µm
AD conversion	16 bits

	Interface		
	Communication interface	Optical fiber	
	Exposure control	Pulse sync in (Edge or level) / Pulse sync out (Edge or level)	
	Work mode	Software mode / HVG sync mode / FPD sync mode	
	Frame speed	18 fps (1x1)	
	Operating system	Windows7 / Windows10 OS 32 bits or 64 bits	

Mechanical	
Dimensions (HxWxD)	322 x 322 x 50.5 mm
Weight	7 kg
Sensor protection material	Carbon fiber
Housing material	Aluminum alloy

Power	
Supply	100~240 VAC
Frequency	50/60 Hz
Consumption	10 W

Environmental	
Temperature range	10~35°C (operating); -10~50°C (storage)
Humidity	30~70% RH (non-condensing)
Vibration	IEC/EN 60721-3 class 2M3 (10~150 Hz, 0.5 g)
Shock	IEC/EN 60721-3 class 2M3 (11 ms, 2 g)
Ingress protection rating	IP41

Technical performance		
Resolution	3.5 lp/mm	
Energy range	40~350 kV	
Lag	<0.8% @1st frame	
Dynamic range	≥86 dB	
Sensitivity	620 lsb/uGy	
SNR	49 dB @ (20000 lsb)	
MTF	72% @ (1 lp/mm)	
	44% @ (2 lp/mm)	
	25% @ (3 lp/mm)	
DQE (2uGy)	66% @ (0 lp/mm)	
	42% @ (1 lp/mm)	
	28% @ (2 lp/mm)	

X-Panel 3030a FPI-M outline

